# 1.24V Adjustable Shunt Regulator

**B431L** 

### **Description**

The B431L is a three terminal adjustable shunt regulator with thermal stability of  $50 ppm/^{\circ}C$ . The output voltage can be adjusted to any value from 1.24V ( $V_{REF}$ ) to 16V with two external resistors. These devices have a typical output impedance of  $0.05\Omega$ . Active output circuitry provides a very sharp turn-on characteristics and making the device excellent replacement for zener diodes in many applications. The B431L is an ideal voltage reference in an isolated feedback circuit for 3.0V switch mode power supplies

The B431L shunt regulator is available with three voltage tolerances (0.5%, 1.0% and 2.0%) and three package options (SOT-23-3, TO-92, 8SOIC). This allows the designer the opportunity to select the optimum combination of cost and performance for their application.

### **Features**

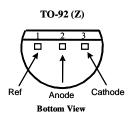
- Low voltage operation (down to 1.24V)
- Wide operating current.....80µA to 100mA
- Trimmed bandgap design..... ± 0.5%
- Low Dynamic Output Impedance......0.05Ω
- Wide temperature range..... -40°C to +85°C
- Available in ......SOT-23-3, TO-92, 8SOIC
- Pin-to-Pin Replacement ......SC431L

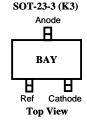
## **Applications**

- Switching Power Supplies
- Adjustable Power Supplies
- Linear Regulators
- Battery Powered Equipment
- Monitors, TV, VCR
- Instrumentation

#### **Pin Connection**







### **Ordering Information**

Package	Tolerance			
	0.5%	1%	2%	
TO-92	B431LAZ	B431LBZ	B431LCZ	
SO-8	B431LAM	B431LBM	B431LCM	
SOT-23	B431LAK3	B431LBK3	B431LCK3	

**Absolute Maximum Rating** 

Parameter	Symbol	Maximum	Units
Cathode Voltage	V <sub>z</sub>	20	V
Continuous Cathode Current	$I_z$	100	mA
Reference Input Current Range		3	mA
Power Dissipation at T <sub>A</sub> - 25°C			
SOT-23-3	$P_{\mathrm{D}}$	0.37	W
S0-8		0.75	
TO-92		0.95	
Thermal Resistance			
SOT-23-3	${ m O_{JA}}$	336	°C/W
S0-8		175	
TO-92		132	
Operating Junction Temperature Range	$T_{J}$	-40 to +150	°C
Storage Temperature Range	$T_{STG}$	-65 to +150	°C
Lead Temperature (Soldering) 10 seconds	$T_{LEAD}$	300	°C
ESD Rating (Human Body Model)	$T_{ESD}$	2	kV

#### **Recommended Operating Conditions**

	Min	Max	Symbol
Cathode Voltage, Vz	$V_{ m REF}$	16	V
Cathode Current, Iz	80μΑ	100	mA

### **Electrical Characteristics**

Unless specified:  $T_{\Lambda = 25^{\circ}C}$ . Values in bold apply over full operating ambient temperature.

			B431LA 0.5%			
Parameter	Symbol	Condition	Min	Тур	Max	Units
Reference Voltage	$V_{REF}$	$V_Z = V_{REF1} I_Z = 10 \text{mA}^{(1)}$	1.234	1.240	1.246	V
			1.222		1.258	
V <sub>REF</sub> Temp Deviation	$V_{ m DEV}$	$V_Z = V_{REF1, I_Z} = 10 \text{mA}^{(1)}$ $I_A = \text{full range}$		10	25	mV
Ratio of Change in $V_{REF}$ To Change in $V_{Z}$	$\frac{\Delta V_{REF}}{\Delta V_{Z}}$	$I_Z = 10 \text{mA}, \Delta V_Z = 16 \text{V to } V_{\text{Ref}}$ (2)		-2.7	-1.0	mV/V
Reference Input Current	$I_{REF}$	R1 = $10k\Omega$ , R2 = $\infty$ , $I_Z = 10mA^{(2)}$		0.15	0.5	μΑ
I <sub>REF</sub> Temperature Deviation	I <sub>REF(DEV)</sub>	R1 = 10kΩ, R2 = ∞, $I_Z = 10mA^{(2)}$		0.1	0.4	μΑ
Off-State Cathode Current	I <sub>Z (OFF)</sub>	$V_{REF} = 0V, V_{Z} = 16V^{(3)}$ $V_{REF} = 0V, V_{Z} = 16V^{(3)}$		0.125	0.150	μA
		$V_{REF} = 0V, V_{Z} = 16V^{(3)}$		0.135	0.150	
Min Operating Current	$I_{Z(MIN)}$	$V_Z = V_{REF}^{(1)}$		20	80	μА
Dynamic Impedance	$Z_{KA}$	$V_{KA}=V_{ref},$ $I_{K}=100\mu A \text{ to } 100\text{mA},  f \leq 1\text{kHA}$		0.05	0.15	Ω

#### **Electrical Characteristics**

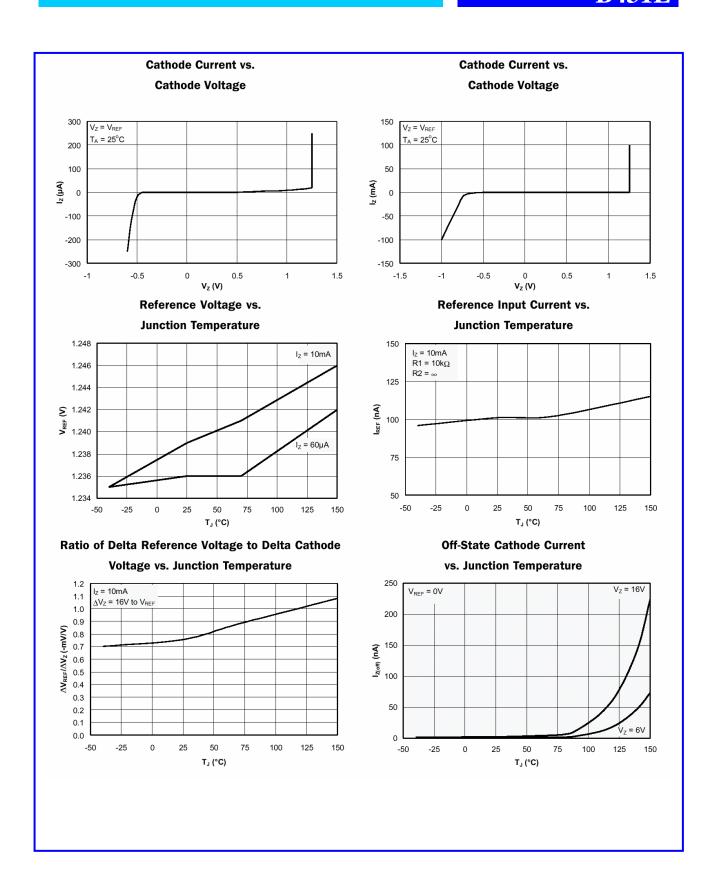
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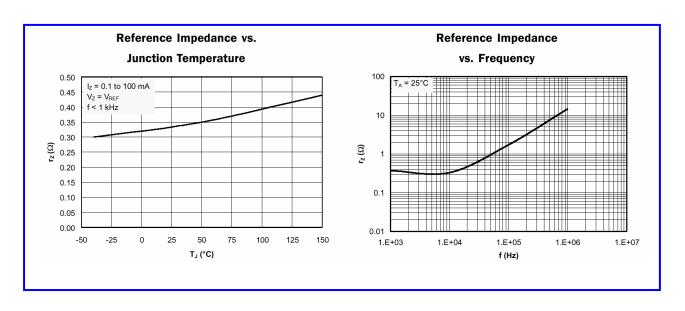
			B431LB 1%			
Parameter	Symbol	Condition	Min	Тур	Max	Units
Reference Voltage	$V_{REF}$	$V_Z = V_{REF1} I_Z = 10 \text{mA}^{(1)}$	1.228	1.240	1.252	V
			1.215	]	1.265	
V <sub>REF</sub> Temp Deviation	$V_{ m DEV}$	$V_Z = V_{REF1}$ , $I_Z = 10 \text{mA}^{(1)}$ $I_A = \text{full range}$		10	25	mV
Ratio of Change in $V_{REF}$ To Change in $V_{Z}$	$\frac{\Delta V_{REF}}{\Delta V_{Z}}$	$I_Z = 10 \text{mA}, \Delta V_Z = 16 \text{V to } V_{\text{Ref}}$ (2)		-1.0	-2.7	mV/V
Reference Input Current	$I_{REF}$	R1 = $10k\Omega$ , R2 = $\infty$ , $I_Z = 10mA^{(2)}$		0.15	0.5	μΑ
I <sub>REF</sub> Temperature Deviation	I <sub>REF(DEV)</sub>	R1 = 10kΩ, R2 = ∞, $I_Z = 10mA^{(2)}$		0.1	0.4	μА
Off-State Cathode Current	I <sub>Z (OFF)</sub>	$V_{REF} = 0V, V_{Z} = 16V^{(3)}$		0.125	0.150	μА
		$V_{REF} = 0V, V_{Z} = 16V^{(3)}$		0.135	0.150	
Min Operating Current	$I_{Z(MIN)}$	$V_Z = V_{REF}^{(1)}$		20	80	μА
Dynamic Impedance	$Z_{KA}$	$V_{KA}=V_{ref}$ , $I_{K}=100\mu A$ to $100mA$ , $f \le 1kHA$		0.05	0.15	Ω

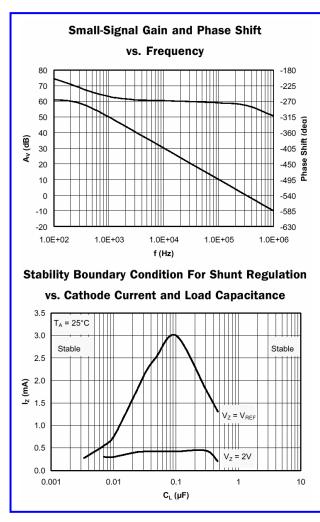
#### **Electrical Characteristics**

Unless specified:  $T_{\Lambda = 25^{\circ}C}$ . Values in bold apply over full operating ambient temperature.

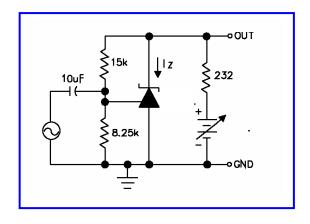
		Condition	B431LC 2%			
Parameter	Symbol		Min	Тур	Max	Units
Reference Voltage	$V_{REF}$	$V_Z = V_{REF1} I_Z = 10 \text{mA}^{(1)}$	1.215	1.240	1.265	V
			1.200	=	1.280	
V <sub>REF</sub> Temp Deviation	$V_{ m DEV}$	$V_Z = V_{REF1, I_Z} = 10 \text{mA}^{(1)}$ $I_A = \text{full range}$		10	35	mV
Ratio of Change in $V_{\text{REF}}$ To Change in $V_{Z}$	$\frac{\Delta V_{REF}}{\Delta V_{Z}}$	$I_Z = 10\text{mA}, \Delta V_Z = 16\text{V to } V_{\text{Ref}}$ (2)		-1.0	-2.7	mV/V
Reference Input Current	$I_{REF}$	$R1 = 10k\Omega, R2 = \infty,$ $I_Z = 10mA^{(2)}$		0.15	0.5	μΑ
I <sub>REF</sub> Temperature Deviation	$I_{REF(DEV)}$	$R1 = 10k\Omega, R2 = \infty,$ $I_Z = 10mA^{(2)}$		0.1	0.4	μА
Off-State Cathode Current	I <sub>Z (OFF)</sub>	$V_{REF} = 0V, V_{Z} = 16V^{(3)}$		0.125	0.150	μА
		$V_{REF} = 0V, V_{Z} = 16V^{(3)}$		0.135	0.150	
Min Operating Current	I <sub>Z(MIN)</sub>	$V_Z = V_{REF}^{(1)}$		20	80	μА
Dynamic Impedance	$Z_{KA}$	$V_{KA}=V_{ref}$ , $I_K=100\mu A$ to $100mA$ , $f\leq 1kHA$		0.05	0.15	Ω



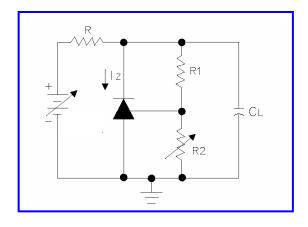




#### **Test Circuit: Small-Signal Gain & Phase**



**Test Circuit: Stability** 



### **Application Notes:**

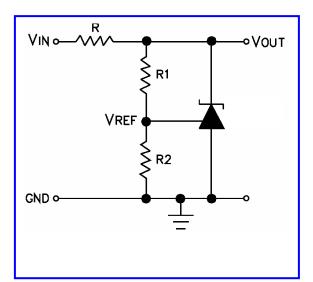
1) Set  $V_{\text{OUT}}$  according to the following equation:

$$V_{OUT} = V_{REF} \left( 1 + \frac{R1}{R2} \right) + I_{REF} R1$$

- 2) Choose the value for R as follows:
- The maximum limit for R should be such that the cathode current,  $I_{7}$ , is greater than the minimum operating current (80µA) at  $V_{IN(MIN)}$ .
- The minimum limit for R should be such that I, does not exceed 100mA under all load conditions, and the instantaneous turn-on value for I<sub>7</sub> does not exceed 150mA. Both of the following conditions must be met:

$$R_{min} \ge \frac{V_{IN(max)}}{150 \text{ mA}} \quad \text{(to limit instantaneous turn-on } I_{z})$$

$$R_{min} \geq \frac{V_{IN(max)} - V_{OUT}}{I_{OUT \, (min)} \, + 100 \, mA} \ \, (to \, limit \, I_{Z} \, under \, \, normal \, \, )$$



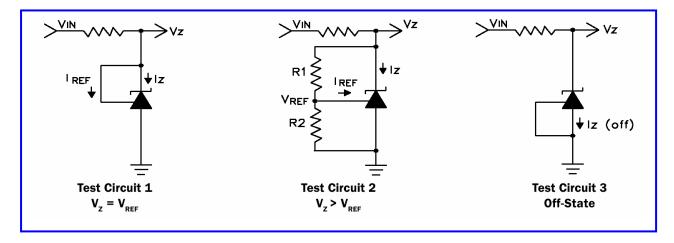
#### Stability: Selection of Load Capacitor

Selection of load capacitor for when B431L is used as a shunt regulator, two options for selection of C<sub>L</sub> 1) No load capacitance across the device, decouple at the load 2) Large capacitance across the device, optional decoupling at the load.

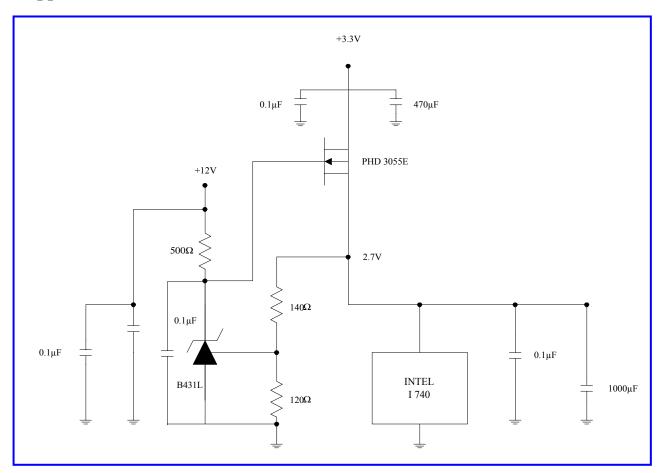
The reason for this is that B431L exhibits instability with capacitances in the range of 10nF to 1µF (approx.) at light cathode currents (up to 3mA typical). The device is less stable the lower the cathode voltage has been set for. Therefore while the device will be perfectly stable operating at a cathode current of 10mA with a 0.1µF capacitor across it, it will oscillate transiently during start-up as the cathode current passes through the instability region. Selecting a very low (or preferably, no) capacitance, or alternatively a high capacitance such as  $10\mu F$  will avoid this issue altogether. Since the user anyway, the most cost effective method is to use no capacitance at all directly across the device. PCB trace/via resistance and inductance prevent the local load decoupling from causing the oscillation during the transient start-up phase.

Note: if the B431L is located right at the load, so the load decoupling capacitor is directly across it, then this capacitor will have to be  $\leq 1 \text{ nF}$  or  $\geq 10 \mu \text{F}$ 

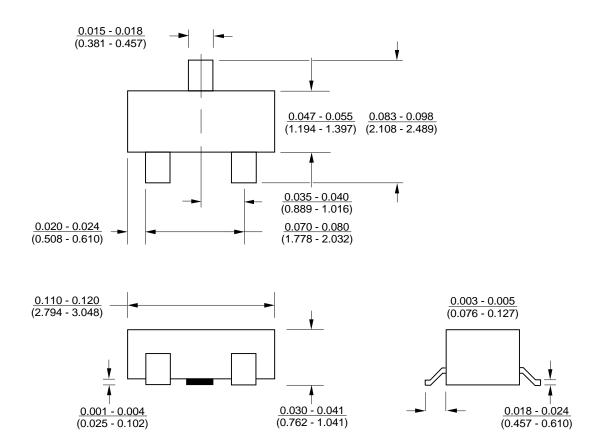
## **Test Circuits:**



# **Application Circuit:**



<sup>\*</sup>If the output voltage has noise, then please add a  $0.1\mu F$  in between drain and gate of power MOSFET to reduce the noise.



Advance Information- These data sheets contain descriptions of products that are in development. The specifications are based on the engineering calculations, computer simulations and/ or initial prototype evaluation.

**Preliminary Information-** These data sheets contain minimum and maximum specifications that are based on the initial device characterizations. These limits are subject to change upon the completion of the full characterization over the specified temperature and supply voltage ranges.

The application circuit examples are only to explain the representative applications of the devices and are not intended to guarantee any circuit design or permit any industrial property right to other rights to execute. Bay Linear takes no responsibility for any problems related to any industrial property right resulting from the use of the contents shown in the data book. Typical parameters can and do vary in different applications. Customer's technical experts must validate all operating parameters including "Typical" for each customer application.

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